Docket No.: 50103-553 **PATENT** 

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of : Customer Number: 20277

Rajiv Yadav RANJAN, et al. : Confirmation Number:

Serial No.: : Group Art Unit:

Filed: February 12, 2004 : Examiner: Unknown

For: METHOD & APPARATUS FOR MULTI-STAGE SPUTTER DEPOSITION OF

UNIFORM THICKNESS LAYERS

## INFORMATION DISCLOSURE STATEMENT

Mail Stop IDS Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sir:

In accordance with the provisions of 37 C.F.R. 1.56, 1.97 and 1.98, the attention of the Patent and Trademark Office is hereby directed to the documents listed on the attached form PTO-1449. It is respectfully requested that the documents be expressly considered during the prosecution of this application, and that the documents be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

This Information Disclosure Statement is being filed within three months of the U.S. filing date OR before the mailing date of a first Office Action on the merits. No certification or fee is required.

## Serial No.:

Please charge any shortage in fees due in connection with the filing of this paper, including extension of time fees, to Deposit Account 500417 and please credit any excess fees to such deposit account.

Respectfully submitted,

MCDERMOTT, WILL & EMERY

Aaron Weisstuch, Ph.D. Registration No. 41,557

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Facsimile: (202) 756-8087 **Date: February 12, 2004** 

INFORMATION DISCLOSURE CITATION IN AN APPLICATION						ATTY. DOCKET NO. <b>50103-553</b>						
						APPLICANT Rajiv Yadav RANJAN, et al.						
(PTO-1449)						FILING DATE GROUP February 12, 2004			P			
U.S. PATENT DOCUMENTS												
EXAMINER'S	1	Document Number			ate I	Name of Patentee or Applicant of Cited			Pages, Columns, Lines, Where			
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1 Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.